

Zeiss Supra 55VP System For Sale

Loaded system: Includes Schottky FESEM with Gemini column, specimen interlock, EDAX Apollo 40 SDD EDS, TSL EBSD, Denton Desk IV TSC turbo fine grain sputter coater, Robinson 8.2 scintillator motorized BSE with joystick control unit, STEM, VPSE detector, CL in high vacuum mode, Haskris R050 chiller, two Liebert Nfinity double conversion UPS units with Ethernet connectivity, Deben XP hot/cold stage. All pumping systems are dry. Latest SmartSEM Zeiss GUI. WindowsXP/Pro SP3 with XP Office Pro. Triple LCD monitors with Zeiss hardpanel with keyboard and mouse to control SEM, EDS and EBSD.

Details can be found here:

System items:

<http://www.microtechnics.com/supra55vp/suprasummary3v2.pdf>

Pictures:

<http://www.microtechnics.com/supra55vp/Page.html>

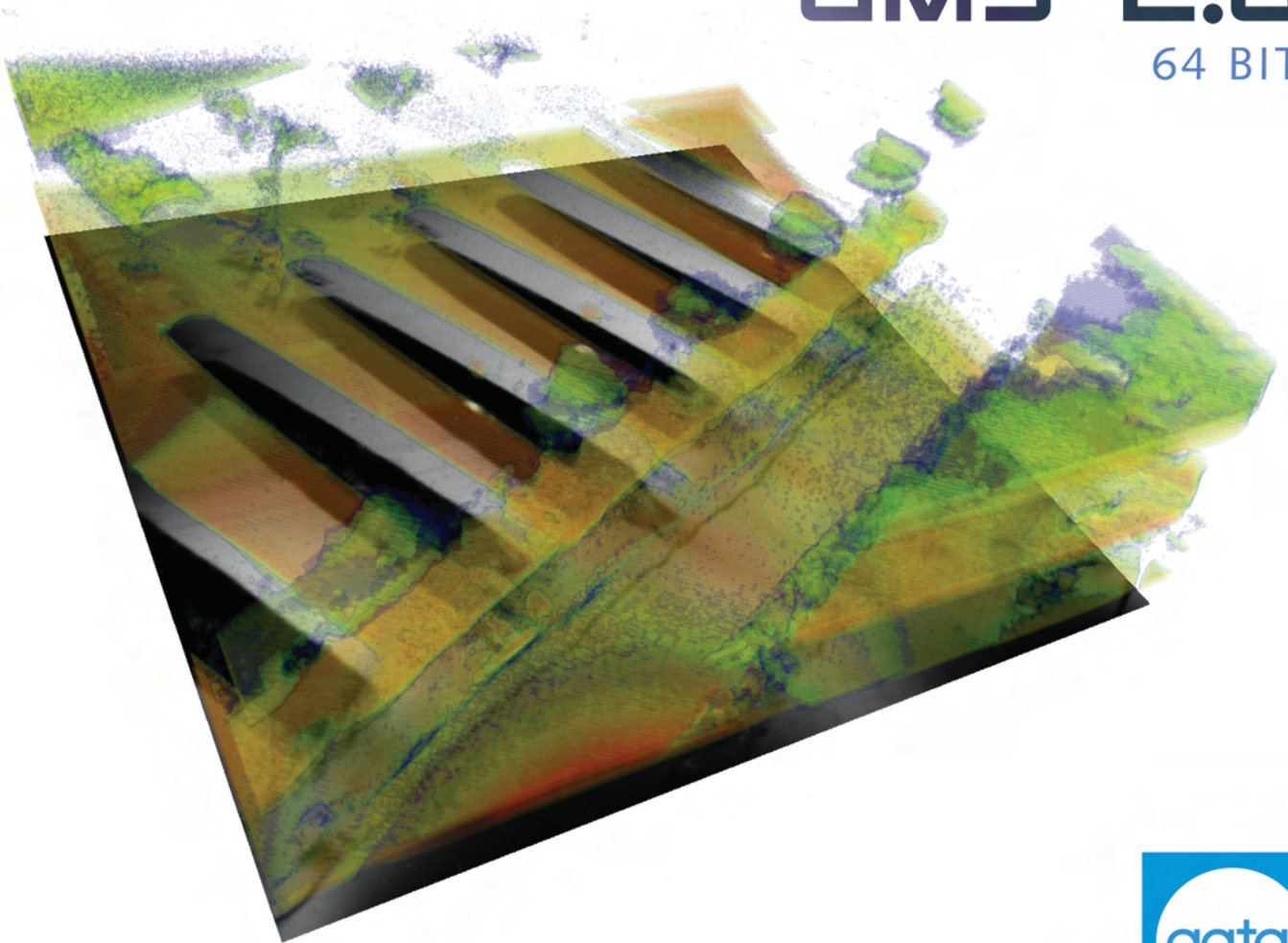
Please inquire with any questions. Asking \$375,000. System has been on maintenance contract since purchase in July 2004, acceptance Jan 2005. Not a refurbished unit. Up and running and can be demonstrated. New tip and alignment. Packing, shipping and insurance and re-install at buyer's cost. Price is negotiable. 916-791-8191 gary@microtechnics.com

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*EDS spectrum image of GaAs, showing
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Data courtesy of Dr. Masashi Watanabe,
Lehigh University*

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